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|---|---------------------------------|--|
| <b>Search Notes</b>   | <b>Application/Control No.</b>  | <b>Applicant(s)/Patent Under Reexamination</b> |
|  | 10714654                        | TAKEKOSHI ET AL.                               |
|   | <b>Examiner</b><br>RANDOLPH CHU | <b>Art Unit</b><br>2624                        |

### SEARCHED

| <b>Class</b> | <b>Subclass</b> | <b>Date</b> | <b>Examiner</b> |
|--------------|-----------------|-------------|-----------------|
| 382          | 100, 128        | 6/6/2007    | ric             |
| 705          | 2.3             | 6/6/2007    | ric             |
| 715          | 716             | 3/20/2008   | ric             |
| 707          | 2               | 3/20/2008   | ric             |
| 382          | 305             | 10/23/2008  | ric             |
| 358          | 403, 404        | 10/23/2008  | ric             |

### SEARCH NOTES

| <b>Search Notes</b>       | <b>Date</b> | <b>Examiner</b> |
|---------------------------|-------------|-----------------|
| EAST                      | 6/6/2007    | ric             |
| Inventor Name Search      | 6/6/2007    | ric             |
| Consult with Wenpeng Chen | 6/6/2007    | ric             |
| Updated EAST Search       | 12/7/2007   | ric             |
| Updated EAST Search       | 3/20/2008   | ric             |
| STIC Search               | 10/23/2008  | ric             |
| Updated EAST Search       | 10/23/2008  | ric             |
| Consult with Andy Johns   | 10/23/2008  | ric             |

### INTERFERENCE SEARCH

| <b>Class</b> | <b>Subclass</b> | <b>Date</b> | <b>Examiner</b> |
|--------------|-----------------|-------------|-----------------|
|              |                 |             |                 |

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